

Notice of References Cited	Application/Control No. 10/810,673		Applicant(s)/Patent Under Reexamination HAN ET AL.	
	Examiner Daniel J. Jenkins		Art Unit 1742	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,607,693	08-2003	Saito et al.	420/417
	B	US-2002/0041819	04-2002	Kumar et al.	419/66
	C	US-6,171,363	01-2001	Shekhter et al.	75/369
	D	US-5,051,218	09-1991	Matthews, M. Dean	264/40.6
	E	US-2005/0084445	04-2005	Kimmel et al.	423/594.17
	F	US-2004/0118247	06-2004	Woodfield et al.	075/351
	G	US-2003/0211001	11-2003	Ivasishin et al.	419/39
	H	US-2002/0041819	04-2002	Kumar et al.	419/66
	I	US-6,521,173	02-2003	Kumar et al.	419/23
	J	US-6,261,337	07-2001	Kumar, Prabhat	75/255
	K	US-6,582,651	06-2003	Cochran et al.	419/5
	L	US-5,011,742	04-1991	Fife et al.	428/558
	M	US-2002/0028175	03-2002	Fife, James A.	423/592

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.